## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10527138	ACKERMANN ET AL.
Examiner	Art Unit
Rutkowski, Jeffrey M	2619

SEARCHED				
Class	Subclass	Date	Examiner	
340	825.52 (topology concepts)	11/16/2007	JMR	
719	310 (topology concepts)	11/16/2007	JMR	
303	3 (topology concepts)	11/16/2007	JMR	
715	771 (topology concepts)	11/16/2007	JMR	
705	14 (topology concepts)	11/16/2007	JMR	

SEARCH NOTES				
Search Notes	Date	Examiner		
text searched EAST for controller area network concepts	11/15/2007	JMR		
text searched EAST for power event triggers	11/15/2007	JMR		
text searched EAST for instrument system concepts	11/15/2007	JMR		

INTERFERENCE SEARCH				
Subclass	Date	Examiner		

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